

3-7-03

Docket No.: 8733.132.20-US (PATENT)

1ARK OFFICE

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of: Joon-Young Yang

Application No.: 09/875,197

Filed: June 7, 2001

For: METHOD OF FABRICATING A THIN FILM

TRANSISTOR

Group Art Unit: 2814

Examiner: S. Rao

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PRELIMINARY AMENDMENT

Box RCE Commissioner for Patents Washington, DC 20231

Dear Sir:

In response to the Examiner's Final Office Action dated November 6, 2002 and Advisory Action dated February 12, 2003, and further to the attached Request for Continued Examination (RCE), please amend the above-identified application as follows.

In the Claims

Please ADD the following new claims:

41. (New) A method of fabricating a thin film transistor, comprising:

forming a gate insulating layer on an active layer;

forming a gate on the gate insulating layer;

forming an excited region in an exposed portion of the active layer by implanting hydrogen ions to the active layer by using the gate as a mask; and

forming an impurity region by heavily implanting impurity ions to said excited region

DC:115800.1